Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,280	FUJII ET AL.	
Examiner	Art Unit	
Steven H. VerSteen	1753	

	SEARCHED		
Class	Subclass	Date	Examiner
204	298.12, 298.41	5/17/2005	· SHV
		*	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	-		
	1		

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY	<b>)</b>
	DATE	EXMR
Inventor name search	5/17/2005	SHV
EAST Search	5/17/2005	SHV
·		